



## 3.3V CMOS OCTAL DUAL-SUPPLY BUS TRANSCEIVER WITH CONFIGURABLE OUTPUT VOLTAGE, 3-STATE OUTPUTS, 5 VOLT I/O

**IDT74LVCC4245A  
ADVANCE INFORMATION**

### FEATURES:

- 0.5 MICRON CMOS Technology
- ESD > 2000V per MIL-STD-883, Method 3015;  
> 200V using machine model ( $C = 200\text{pF}$ ,  $R = 0$ )
- 1.27mm pitch SOIC, 0.65mm pitch SSOP,  
0.635mm pitch QSOP, 0.65mm pitch TSSOP packages
- Extended commercial range of  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$
- $V_{CC} = 3.3\text{V} \pm 0.3\text{V}$ , Normal Range
- $V_{CC} = 2.3\text{V}$  to  $3.6\text{V}$ , Extended Range
- CMOS power levels ( $0.4\mu\text{W}$  typ. static)
- Rail-to-Rail output swing for increased noise margin
- All inputs, outputs and I/O are 5 Volt tolerant
- Supports hot insertion

### Drive Features for LVCC4245A:

- High Output Drivers:  $\pm 24\text{mA}$
- Reduced system switching noise

### APPLICATIONS:

- 5V and 3.3V mixed voltage systems
- Data communication and telecommunication systems

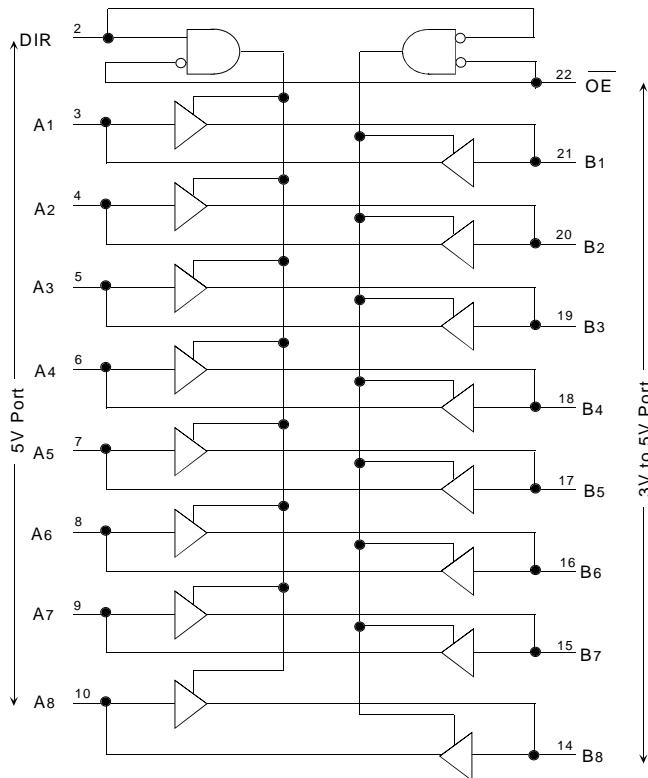
### DESCRIPTION:

The LVCC4245A is built using advanced dual metal CMOS technology. This 8-bit (octal) noninverting bus transceiver contains two separate power-supply rails. The configurable B port is designed to track  $V_{CCB}$ , which accepts voltages from 3V to 5V, and the A port is dedicated to accept a 5V supply level. This allows for translation from a 3.3V to a 5V system environment and vice-versa.

This LVCC4245A is ideal for asynchronous communication between two data buses (A and B). The device transmits data from A to B or from B to A, depending on the logic level at the direction-control (DIR) input. The output-enable ( $OE$ ) input can be used to disable the device so the buses are effectively isolated.

The LVCC4245A has been designed with a  $\pm 24\text{mA}$  output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

### Functional Block Diagram



**EXTENDED COMMERCIAL TEMPERATURE RANGE**

**APRIL 1999**

## PIN CONFIGURATION

(5V) VCCA	1	24	VCCB (3V to 5V)
DIR	2	23	NC
A1	3	22	OE
A2	4	21	B1
A3	5	20	B2
A4	6	19	SO24-2
A5	7	18	SO24-7
A6	8	17	SO24-8
A7	9	16	SO24-9
A8	10	15	B5
GND	11	14	B6
GND	12	13	B7
			B8
			GND

SOIC/ SSOP/ QSOP/ TSSOP  
TOP VIEW

## PIN DESCRIPTION

Pin Names	Description
OE	Output Enable Input (Active LOW)
DIR	Direction Control Input
Ax	Side A Inputs or 3-State Outputs
Bx	Side B Inputs or 3-State Outputs
NC	No Internal Connection

## FUNCTION TABLE (1)

Inputs		Outputs
OE	DIR	
L	L	Bus B Data to Bus A
L	H	Bus A Data to Bus B
H	X	High Z State

### NOTE:

1. H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Don't Care

## ABSOLUTE MAXIMUM RATING

### FOR VCCA (1)

Symbol	Description	Max.	Unit
VTERM <sup>(2)</sup>	Terminal Voltage with Respect to GND	- 0.5 to +6	V
VTERM <sup>(3)</sup>	Terminal Voltage with Respect to GND	- 0.5 to VCCA+0.5	V
TSTG	Storage Temperature	- 65 to +150	°C
IOUT	DC Output Current	- 50 to +50	mA
I <sub>IK</sub>	Continuous Clamp Current, Vi < 0 or Vo < 0	- 50	mA
I <sub>CC</sub>	Continuous Current through each Vcc or GND	± 100	mA
I <sub>SS</sub>			

## ABSOLUTE MAXIMUM RATING

### FOR VCCB (1)

Symbol	Description	Max.	Unit
VTERM <sup>(2)</sup>	Terminal Voltage with Respect to GND	- 0.5 to +6	V
VTERM <sup>(3)</sup>	Terminal Voltage with Respect to GND	- 0.5 to VCCB+0.5	V
TSTG	Storage Temperature	- 65 to +150	°C
IOUT	DC Output Current	- 50 to +50	mA
I <sub>IK</sub>	Continuous Clamp Current, Vi < 0 or Vo < 0	- 50	mA
I <sub>CC</sub>	Continuous Current through each Vcc or GND	± 100	mA
I <sub>SS</sub>			

### NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Vcc terminals.
3. All terminals except Vcc.

## CAPACITANCE (TA = +25°C, f = 1.0MHz)

Symbol	Parameter <sup>(1)</sup>	Conditions	Typ.	Max.	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	5	—	pF
C <sub>I/O</sub>	I/O Port Capacitance	V <sub>IN</sub> = 0V	11	—	pF

### NOTE:

1. As applicable to the device type.

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE (A PORT)

Following Conditions Apply Unless Otherwise Specified:

Operating Condition: TA = -40°C To +85°C; VCCA = 4.5V to 5.5V<sup>(1)</sup>

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(2)</sup>	Max.	Unit
VIH	Input HIGH Voltage Level	VCCA = 4.5V, VCCB = 2.7V	VOB ≤ 0.1V or VOB ≥ VCCB - 0.1V	2	—	—	V
		VCCA = 4.5V, VCCB = 3.6V		2	—	—	
		VCCA = 5.5V, VCCB = 5.5V		2	—	—	
VIL	Input LOW Voltage Level	VCCA = 4.5V, VCCB = 2.7V	—	—	—	0.8	V
		VCCA = 4.5V, VCCB = 3.6V		—	—	0.8	
		VCCA = 5.5V, VCCB = 5.5V		—	—	0.8	
I <sub>IIH</sub> I <sub>IL</sub>	Input Leakage Current (Control Inputs)	VCCA = 5.5V VCCB = 3.6V or 5.5V	VI = 0 to 5.5V	—	—	±1	µA
I <sub>OZH</sub> I <sub>OZL</sub>	High Impedance Output Current (3-State Output pins)	VCCA = 5.5V VCCA = 3.6V	VO = 0 to 5.5V	—	—	±5	µA
V <sub>IK</sub>	Clamp Diode Voltage	VCCA = 4.5V, I <sub>IN</sub> = -18mA	—	—	-0.7	-1.2	V
V <sub>H</sub>	Input Hysteresis	VCCA = 5.0V	—	100	—	mV	
I <sub>CCL</sub> I <sub>CCH</sub>	Quiescent Power Supply Current	VCCA = 5.5V VCCB = 3.6V or 5.5V	VIN = GND or VCCA IOB = 0	—	—	80	µA
ΔI <sub>CC</sub>	Quiescent Power Supply Current Variation	One input at 3.4V, other inputs at VCCA or GND		—	—	1.5	mA

NOTES:

1. VCCB = 2.7V to 5.5V unless otherwise noted.
2. Typical values are at VCCA = 5.0V, +25°C ambient.

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE (B PORT)

Following Conditions Apply Unless Otherwise Specified:

Operating Condition: TA = -40°C To +85°C; VCCB = 2.7V to 5.5V<sup>(1)</sup>

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(2)</sup>	Max.	Unit
VIH	Input HIGH Voltage Level	VCCB = 2.7V, VCCA = 4.5V	VOA ≤ 0.1V or VOA ≥ VCCA - 0.1V	2	—	—	V
		VCCB = 3.6V, VCCA = 4.5V		2	—	—	
		VCCB = 5.5V, VCCA = 5.5V		3.85	—	—	
VIL	Input LOW Voltage Level	VCCB = 2.7V, VCCA = 4.5V	—	—	—	0.8	V
		VCCB = 3.6V, VCCA = 4.5V		—	—	0.8	
		VCCB = 5.5V, VCCA = 5.5V		—	—	1.65	
I <sub>OZH</sub> I <sub>OZL</sub>	High Impedance Output Current (3-State Output pins)	VCCB = 3.6V VCCA = 5.5V	VO = 0 to 5.5V	—	—	±5	µA
V <sub>IK</sub>	Clamp Diode Voltage	VCCB = 2.3V, I <sub>IN</sub> = -18mA	—	—	-0.7	-1.2	V
V <sub>H</sub>	Input Hysteresis	VCCB = 3.3V	—	100	—	mV	
I <sub>CCL</sub> I <sub>CCH</sub>	Quiescent Power Supply Current	VCCB = 3.6V or 5.5V VCCA = 5.5V	VIN = GND or VCCB IOA = 0	—	—	80	µA
ΔI <sub>CC</sub>	Quiescent Power Supply Current Variation	One input at VCCB - 0.6V, other inputs at VCCB or GND		—	—	500	µA

NOTES:

1. VCCA = 4.5V to 5.5V unless otherwise noted.
2. Typical values are at VCCB = 3.3V, +25°C ambient.

## OUTPUT DRIVE CHARACTERISTICS (A PORT)

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Max.	Unit
VOH	Output HIGH Voltage (B port to A port)	VCCA = 4.5V, VCCB = 3V	I <sub>OH</sub> = -0.1mA	4.4	—	V
			I <sub>OH</sub> = -24mA	3.76	—	
VOL	Output LOW Voltage (B port to A port)	VCCA = 4.5V, VCCB = 3V	I <sub>OL</sub> = 0.1mA	—	0.1	V
			I <sub>OL</sub> = 24mA	—	0.44	

**NOTE:**

1. V<sub>IH</sub> and V<sub>IL</sub> must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate Vcc range. T<sub>A</sub> = -40°C to +85°C.

## OUTPUT DRIVE CHARACTERISTICS (B PORT)

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Max.	Unit
VOH	Output HIGH Voltage (A port to B port)	VCCB = 3V	I <sub>OH</sub> = -0.1mA	2.9	—	V
		VCCB = 2.7V	I <sub>OH</sub> = -12mA	2.2	—	
		VCCB = 3V		2.46	—	
		VCCB = 2.7V	I <sub>OH</sub> = -24mA	2.1	—	
		VCCB = 3V		2.25	—	
		VCCB = 4.5V		3.76	—	
VOL	Output LOW Voltage (A port to B port)	VCCB = 3V	I <sub>OL</sub> = 0.1mA	—	0.1	V
		VCCB = 2.7V	I <sub>OL</sub> = 12mA	—	0.44	
		VCCB = 2.7V	I <sub>OL</sub> = 24mA	—	0.5	
		VCCB = 3V		—	0.44	
		VCCB = 4.5V		—	0.44	

**NOTE:**

1. V<sub>IH</sub> and V<sub>IL</sub> must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate Vcc range. T<sub>A</sub> = -40°C to +85°C, V<sub>CCA</sub> = 4.5V.

## OPERATING CHARACTERISTICS, T<sub>A</sub> = 25°C

Symbol	Parameter	Test Conditions	V <sub>CBA</sub> = 5V	Unit
			V <sub>CBB</sub> = 3.3V	
CPD	Power Dissipation Capacitance per transceiver Outputs Enabled	CL = 0pF, f = 10Mhz	20	pF
	Power Dissipation Capacitance per transceiver Outputs Disabled		6.5	

## SWITCHING CHARACTERISTICS <sup>(1)</sup>

Symbol	Parameter	$V_{CCA} = 5V \pm 0.5V$				Unit	
		$V_{CCB} = 5V \pm 0.5V$		$V_{CCB} = 2.7V$ to $3.6V$			
		Min.	Max.	Min.	Max.		
$t_{PHL}$	Propagation Delay Ax to Bx	1	7.1	1	7	ns	
		1	6	1	7		
$t_{PLH}$	Propagation Delay Bx to Ax	1	6.8	1	6.2	ns	
		1	6.1	1	5.3		
$t_{PZL}$	Output Enable Time $\overline{OE}$ to Bx	1	8.2	1	10	ns	
		1	8.1	1	10.2		
$t_{PZL}$	Output Enable Time $\overline{OE}$ to Ax	1	9	1	9	ns	
		1	8.3	1	8		
$t_{PLZ}$	Output Disable Time $\overline{OE}$ to Ax	1	4.7	1	5.2	ns	
		1	4.9	1	5.2		
$t_{PHZ}$	Output Disable Time $\overline{OE}$ to Bx	1	5.4	1	5.4	ns	
		1	6.3	1	7.4		
$t_{SK(0)}$	Output Skew <sup>(2)</sup>	—	—	—	500	ps	

**NOTES:**

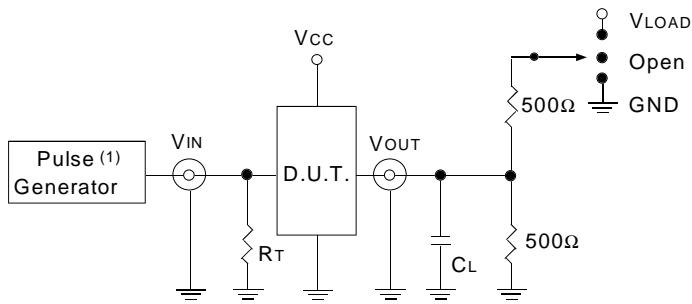
1. See test circuits and waveforms.  $T_A = -40^\circ C$  to  $+85^\circ C$ .
2. Skew between any two outputs of the same package and switching in the same direction.

## TEST CIRCUITS AND WAVEFORMS

### TEST CONDITIONS

Symbol	V <sub>CCA</sub> = 4.5V to 5.5V <sup>(1)</sup> V <sub>CCB</sub> = 2.7V to 3.6V	V <sub>CCA</sub> = 4.5V to 5.5V V <sub>CCB</sub> = 3.6V to 5.5V	Unit
V <sub>LOAD</sub>	2xV <sub>CCA</sub>	2xV <sub>CCA</sub>	V
V <sub>IH</sub>	3	V <sub>CCB</sub>	V
V <sub>T</sub>	1.5	V <sub>CCB</sub> /2	V
V <sub>LZ</sub>	300	300	mV
V <sub>HZ</sub>	300	300	mV
C <sub>L</sub>	50	50	pF

### TEST CIRCUITS FOR ALL OUTPUTS



#### DEFINITIONS:

CL = Load capacitance: includes jig and probe capacitance.  
RT = Termination resistance: should be equal to Z<sub>OUT</sub> of the Pulse Generator.

#### NOTE:

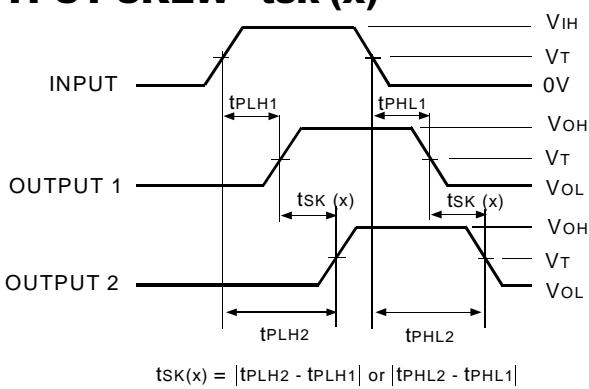
1. Pulse Generator for All Pulses: Rate  $\leq$  10MHz; t<sub>F</sub>  $\leq$  2.5ns; t<sub>R</sub>  $\leq$  2.5ns.

### SWITCH POSITION

Test	Switch
Open Drain	V <sub>LOAD</sub>
Disable Low	
Enable Low	GND
Disable High	
Enable High	
All Other tests	Open

8LVC Link

### OUTPUT SKEW - t<sub>SK</sub> (x)

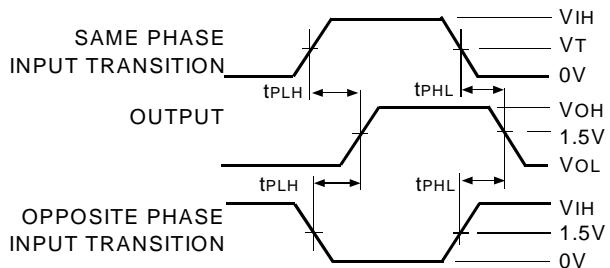


$$t_{SK}(x) = |t_{PLH2} - t_{PLH1}| \text{ or } |t_{PHL2} - t_{PHL1}|$$

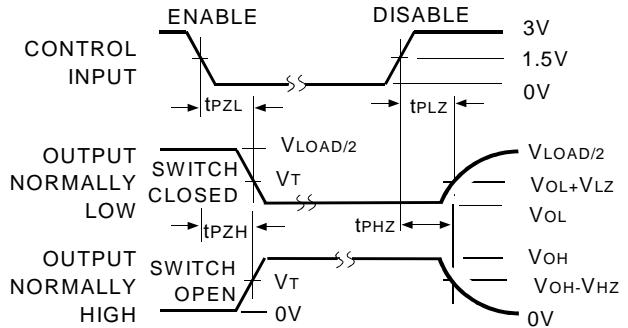
#### NOTES:

1. For t<sub>SK</sub>(o) OUTPUT1 and OUTPUT2 are any two outputs.
2. For t<sub>SK</sub>(b) OUTPUT1 and OUTPUT2 are in the same bank.

### PROPAGATION DELAY



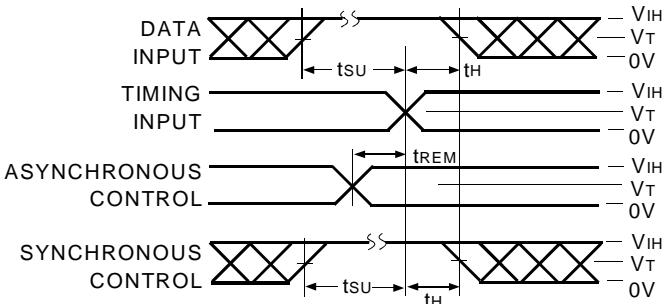
### ENABLE AND DISABLE TIMES



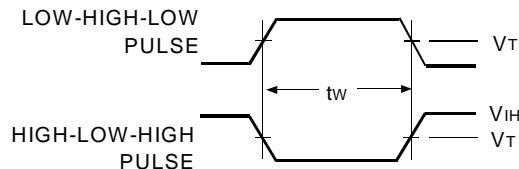
#### NOTE:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

### SET-UP, HOLD, AND RELEASE TIMES



### PULSE WIDTH



## ORDERING INFORMATION

IDT	XX	LVC	X	XXXX	XX	
Temp. Range		Bus-Hold		Device Type	Package	
					SO	Small Outline IC (gull wing) (SO24-2)
					PY	Shrink Small Outline Package (SO24-7)
					Q	Quarter Size Small Outline Package (SO24-8)
					PG	Thin Shrink Small Outline Package (SO24-9)
				C4245A		Octal Dual-Supply Bus Transceiver with Configurable Output Voltage and 3-State Outputs, $\pm 24\text{mA}$
					Blank	No Bus-Hold
				74		$-40^\circ\text{C}$ to $+85^\circ\text{C}$



### CORPORATE HEADQUARTERS

2975 Stender Way  
Santa Clara, CA 95054

### for SALES:

800-345-7015 or 408-727-6116  
fax: 408-492-8674  
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